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# N-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)	
	0.056 at V <sub>GS</sub> = 10 V	4.8		
20	0.059 at V <sub>GS</sub> = 4.5 V	4.8	7.9 nC	
	0.064 at V <sub>GS</sub> = 2.5 V	4.5		

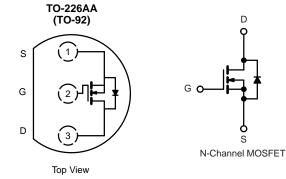


- DT-Trench Power MOSFET
- 100 % Rg Tested

#### **APPLICATIONS**

· Load Switch





Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	20	V	
Gate-Source Voltage		V <sub>GS</sub>	± 12	v	
	T <sub>C</sub> = 25 °C		4.8 <sup>a</sup>		
Continuous Drain Current (T 150 °C)a	T <sub>C</sub> = 70 °C	1-	4.5 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 25 °C	I <sub>D</sub>	4.8 <sup>a, b, c</sup>		
	T <sub>A</sub> = 70 °C		4.5 <sup>a, b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	20		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	la la	4.5 <sup>a</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	2.9 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		1.9		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	PD	1.2	w	
	T <sub>A</sub> = 25 °C	' D	0.5 <sup>b, c</sup>	vv	
	T <sub>A</sub> = 70 °C		0.2 <sup>b, c</sup>	1	
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature)		-	260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient	t ≤ 5 s	R <sub>thJA</sub>	28	36	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	5.3	6.5	0/11	

Notes:

a. Package limitedb. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

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<b>SPECIFICATIONS</b> $T_J = 25 \circ C$		erwise noted					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					1		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_{D} = 250 \mu A$	20			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μΑ		25		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 3.7			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.6		1.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 12 V$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			1	μA	
	200	$V_{DS}$ = 20 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			10	, ., .	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \leq~5$ V, $V_{GS}$ = $~4.5$ V		20		A	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.8 A		0.056	0.062	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 4.8 \text{ A}$		0.059	0.065		
		$V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 4.8 \text{ A}$		0.064	0.070		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 4.8 A		20		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			1020		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		160			
Reverse Transfer Capacitance	C <sub>rss</sub>			70			
•		$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 4.8 \text{ A}$		17.5	27	nC	
Total Gate Charge	Qg			7.9	16		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 10 V, $V_{GS}$ = 4.5 V, $I_{D}$ = 4.8 A		2.1			
Gate-Drain Charge	Q <sub>gd</sub>			1.1			
Gate Resistance	Rg	f = 1 MHz	0.6	3	6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			12	18		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 1.3 $\Omega$		11	17	- ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_{\text{D}}\cong$ 3.9 A, $\text{V}_{\text{GEN}}$ = 4.5 V, $\text{R}_{g}$ = 1 $\Omega$		27	41		
Fall Time	t <sub>f</sub>			11	17		
Turn-On Delay Time	t <sub>d(on)</sub>			7	14		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 1.3 $\Omega$		10	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ 3.9 A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		20	30		
Fall Time	t <sub>f</sub>			8	16		
Drain-Source Body Diode Characteris	tics						
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			4.5 <sup>c</sup>		
Pulse Diode Forward Current	I <sub>SM</sub>				20	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 3.9 A, V <sub>GS</sub> = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			16	24	ns	
Body Diode Reverse Recovery Charge	barge O			6	12	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 7.9 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$		7		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			8			

Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

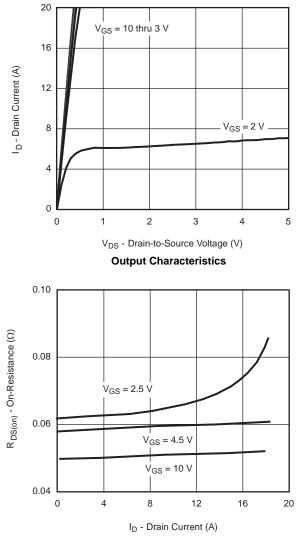
c. Package Limited

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

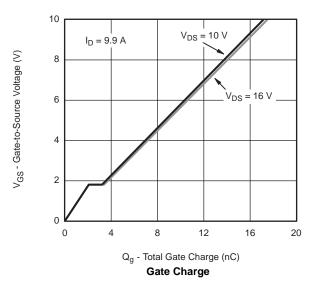
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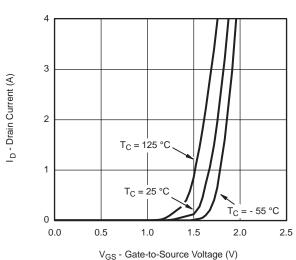
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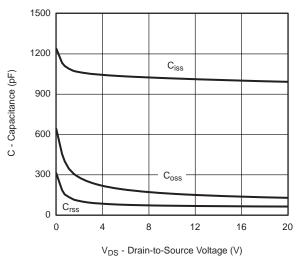


On-Resistance vs. Drain Current and Gate Voltage

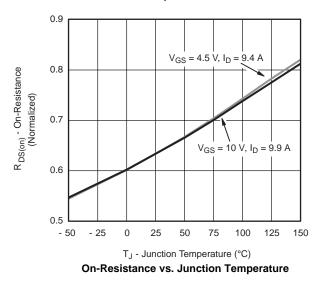




Transfer Characteristics



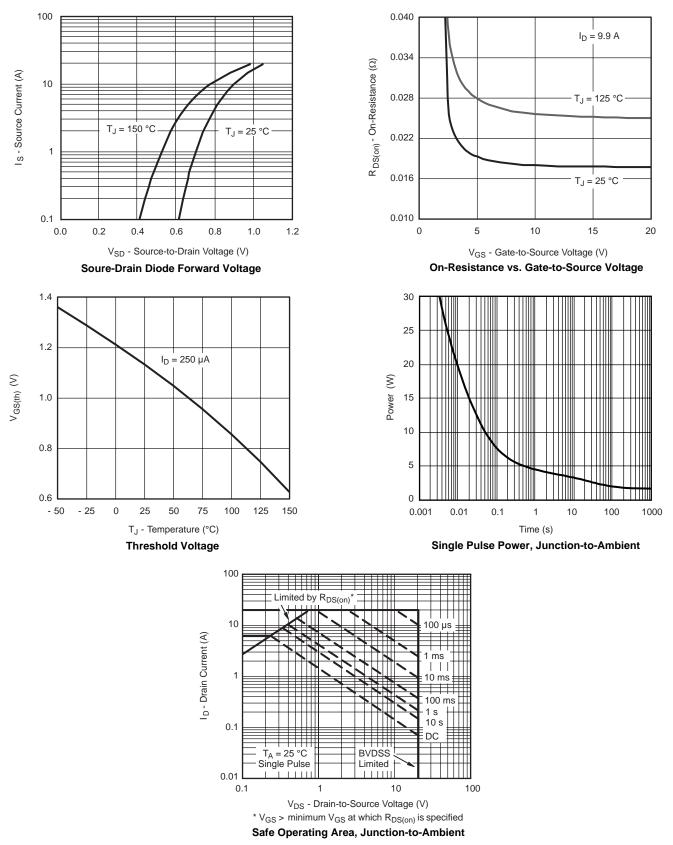
Capacitance



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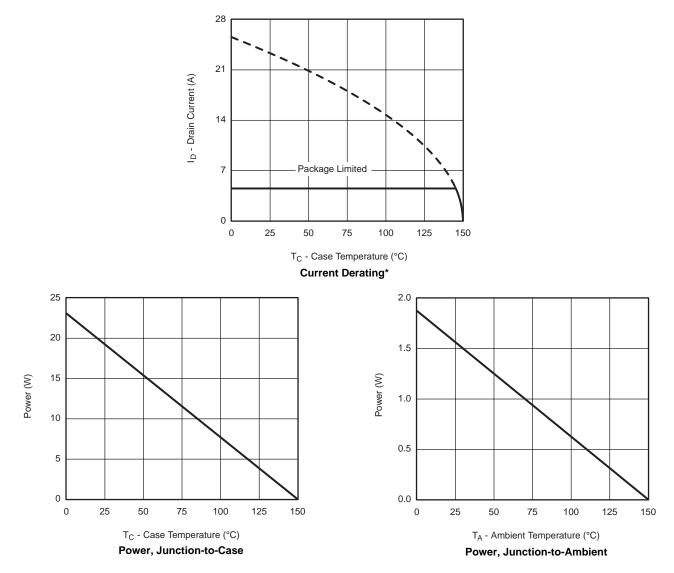
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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





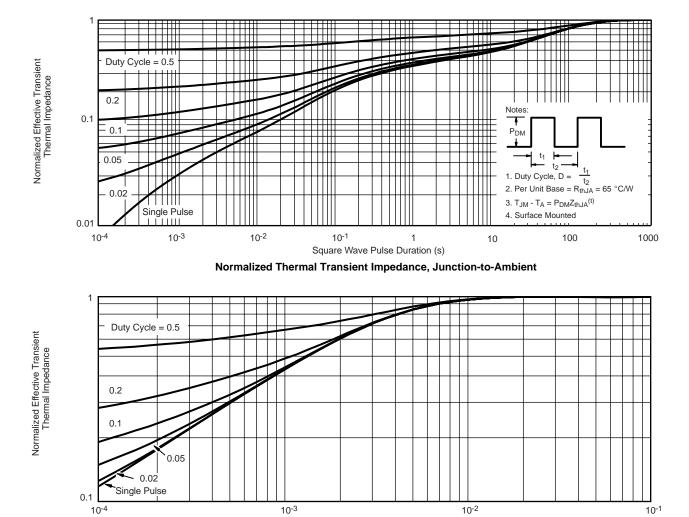
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\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Square Wave Pulse Duration (s) Normalized Thermal Transient Impedance, Junction-to-Case



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